

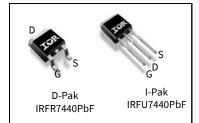
IRFR7440PbF IRFU7440PbF

Application

- Brushed Motor drive applications
- BLDC Motor drive applications .
- PWM Inverterized topologies •
- •
- Battery powered circuits Half-bridge and full-bridge topologies Electronic ballast applications •
- Synchronous rectifier applications •
- Resonant mode power supplies
- OR-ing and redundant power switches •
- DC/DC and AC/DC converters ٠

StrongIRFET[™] power MOSFET

	0 1	
	V _{DSS}	40V
	R _{DS(on)} typ.	1.9m Ω
_(🛶 本)	max	2.4m Ω
G	D (Silicon Limited)	180A ①
S	D (Package Limited)	90A



G	D	S
Gate	Drain	Source

Improved	Gate, Avalanche and Dynamic dV/dt Ruggedness
	astarized Canaditanaa and Avalanaha COA

Benefits

- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dV/dt and dI/dt Capability
- Lead-Free, RoHS Compliant containing no Lead, no Bromide, and no Halogen

Base part number	Backago Typo	Standard Pack		Orderable Part Number
Base part number	Package Type	Form	Quantity	
IRFR7440PbF	D-Pak	Tube	75	IRFR7440PbF
	D-Pak	Tape and Reel	2000	IRFR7440TRPbF
IRFU7440PbF	I-Pak	Tube	75	IRFU7440PbF

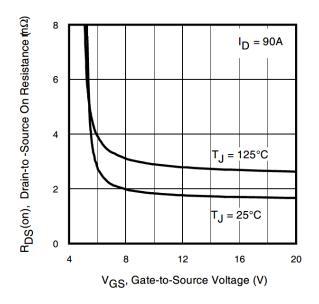
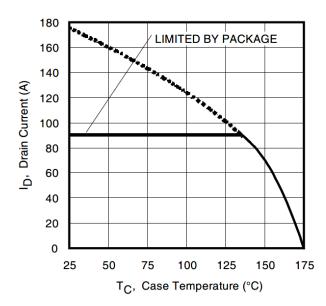
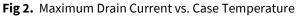


Fig 1. Typical On-Resistance vs. Gate Voltage







Absolute Maximum Rating

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	180①	
$I_D @ T_C = 100^{\circ}C$	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	125①	•
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Wire Bond Limited)	90	— A
I _{DM}	Pulsed Drain Current ②	760	
P _D @T _c = 25°C	Maximum Power Dissipation	140	W
	Linear Derating Factor	0.95	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
dv/dt	Peak Diode Recovery ④	4.4	V/ns
Tj T _{stg}	Operating Junction and Storage Temperature Range	-55 to +175	°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	7

Avalanche Characteristics

EAS (Thermally limited)	Single Pulse Avalanche Energy ③	160	mJ
EAS (Thermally limited)	Single Pulse Avalanche Energy 🐵	376	IIIJ
I _{AR}	Avalanche Current ②	See Fig 15, 16, 23a, 23b	А
E _{AR}	Repetitive Avalanche Energy ②	Jee 1 1g 1J, 10, 230, 230	mJ

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
R _{θJC}	Junction-to-Case ⑨		1.05	
$R_{ ext{ heta}JA}$	Junction-to-Ambient (PCB Mount) ⑧		50	°C/W
$R_{ heta JA}$	Junction-to-Ambient ⑨		110	

Static @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	40			V	V _{GS} = 0V, I _D = 250μA ②
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		28		mV/°C	Reference to 25°C, I _D = 1mA
D	Static Drain-to-Source On-Resistance		1.9	2.4		V _{GS} = 10V, I _D = 90A ⑤
R _{DS(on)}			2.8		mΩ	V _{GS} = 6.0V, I _D = 50A ⑤
V _{GS(th)}	Gate Threshold Voltage	2.2	3.0	3.9	V	$V_{DS} = V_{GS}, I_D = 100 \mu A$
	Drain-to-Source Leakage Current			1.0		$V_{DS} = 40V, V_{GS} = 0V$
I _{DSS}	Dialit-to-Source Leakage Current			150	μΑ	$V_{DS} = 40V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
	Gate-to-Source Forward Leakage			100	nA	$V_{GS} = 20V$
I _{GSS}	Gate-to-Source Reverse Leakage			-100	ΠA	$V_{GS} = -20V$
R _G	Gate Resistance		2.6		Ω	

Notes:

- ① Calculated continuous current based on maximum allowable junction temperature. Bond wire current limit is 90A by source bonding technology. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements. (Refer to AN-1140)
- ② Repetitive rating; pulse width limited by max. junction temperature.
- ③ Limited by T_{Jmax} , starting $T_J = 25^{\circ}$ C, L = 0.04mH, $R_G = 50\Omega$, $I_{AS} = 90A$, $V_{GS} = 10V$.
- $\label{eq:ISD} \textcircled{4mu} I_{SD} \leq 100 A, \, di/dt \leq 1306 A/\mu s, \, V_{DD} \leq V_{(BR)DSS}, \, T_J \leq 175^{\circ} C.$
- Pulse width \leq 400 μ s; duty cycle \leq 2%.
- © Coss eff. (TR) is a fixed capacitance that gives the same charging time as Coss while VDS is rising from 0 to 80% VDSS.
- \odot C_{oss} eff. (ER) is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.please refer to application note to AN-994
- (9) R_{θ} is measured at T_J approximately 90°C.
- Imited by T_{Jmax} , starting $T_J = 25^{\circ}C$, L = 1mH, $R_G = 50\Omega$, $I_{AS} = 27A$, $V_{GS} = 10V$.

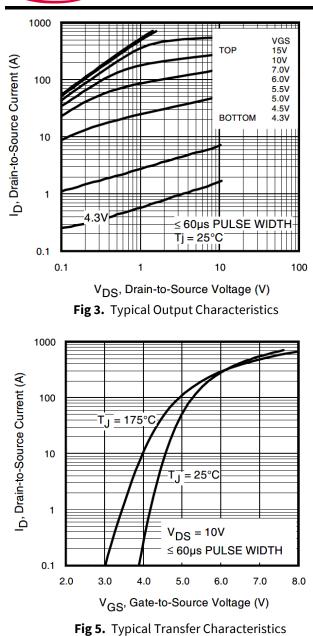
IRFR7440PbF/IRFU7440PbF

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
gfs	Forward Transconductance	280			S	V _{DS} = 10V, I _D =90A
Qg	Total Gate Charge		89	134		
Q _{gs}	Gate-to-Source Charge		26			$I_{D} = 90A$
Q _{gd}	Gate-to-Drain Charge		26		nC	$V_{DS} = 20V$ $V_{GS} = 10V$
Qsync	Total Gate Charge Sync. (Qg– Qgd)		63			VGS - 10V
t _{d(on)}	Turn-On Delay Time		11			$V_{DD} = 20V$
t _r	Rise Time		39			I _D = 30A
t _{d(off)}	Turn-Off Delay Time		51		ns	R_{G} = 2.7 Ω
t _f	Fall Time		34			V _{GS} = 10V⑤
C _{iss}	Input Capacitance		4610			$V_{GS} = 0V$
Coss	Output Capacitance		690			V _{DS} = 25V
C _{rss}	Reverse Transfer Capacitance		460		pF	<i>f</i> = 1.0MHz, See Fig.7
Coss eff.(ER)	Effective Output Capacitance (Energy Related)		855			$V_{GS} = 0V, VDS = 0V \text{ to } 32V$
Coss eff.(TR)	Output Capacitance (Time Related)		1210			$V_{GS} = 0V, VDS = 0V \text{ to } 32V$
Diode Char	acteristics					
Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
ls	Continuous Source Current			180①		MOSFET symbol

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter Min. Typ.	Max.	Units	Conditions	
ls	Continuous Source Current (Body Diode)	 	180①		MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ②	 	760 integral reverse p-n junction diode.		integral reverse
V _{SD}	Diode Forward Voltage	 0.9	1.3	V	$T_J = 25^{\circ}C, I_S = 90A, V_{GS} = 0V$ (5)
t _{rr}	Reverse Recovery Time	 34		ns	$T_J = 25^{\circ}C$ $V_R = 34V$
Lrr	Reverse Recovery fille	 35			T ₁ = 125°C
0	Reverse Recovery Charge	 33		nC	$I_{\rm J} = 25^{\circ}{\rm C}$ $I_{\rm F} = 90{\rm A}$
Q _{rr}		 34			T _J = 125°C di/dt = 100A/μs ⑤
RRM	Reverse Recovery Current	 1.8		Α	T, = 25°C

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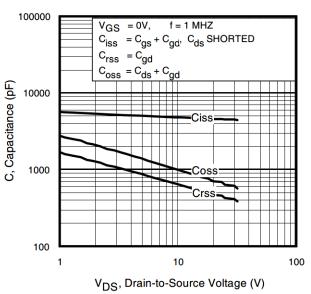
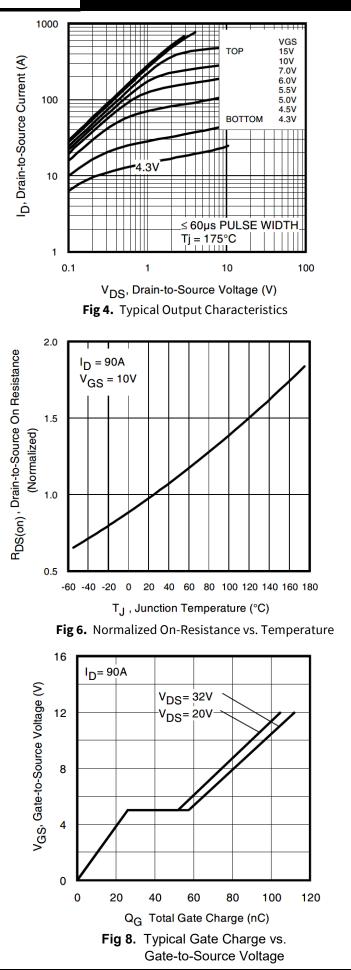


Fig 7. Typical Capacitance vs. Drain-to-Source Voltage

IRFR7440PbF/IRFU7440PbF



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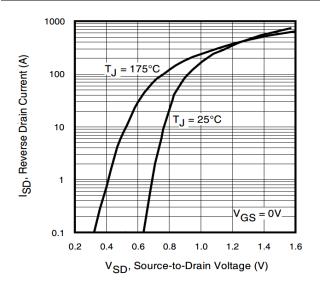


Fig 9. Typical Source-Drain Diode Forward Voltage

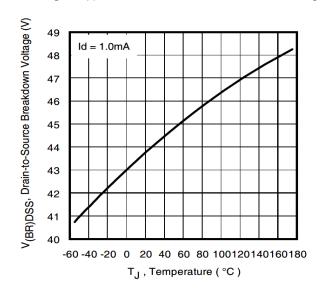


Fig 11. Drain-to-Source Breakdown Voltage

IRFR7440PbF/IRFU7440PbF

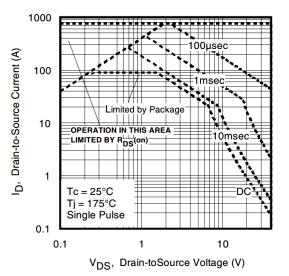


Fig 10. Maximum Safe Operating Area

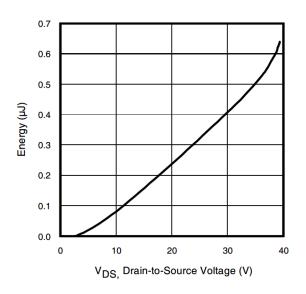
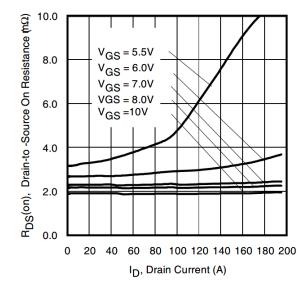
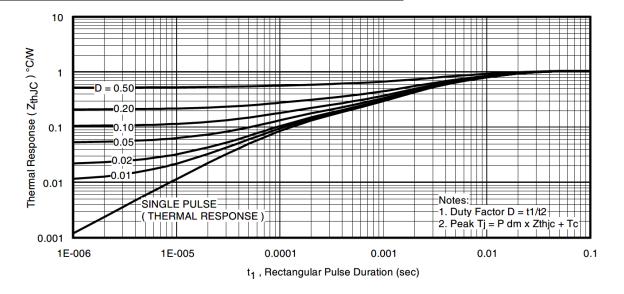
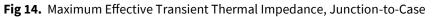


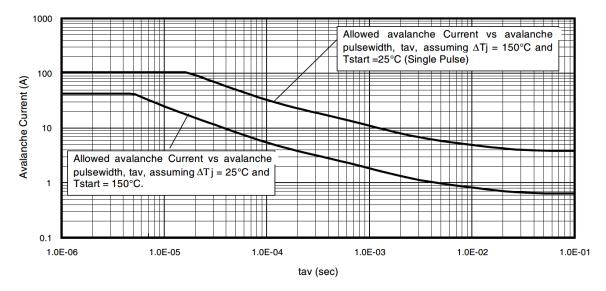
Fig 12. Typical Coss Stored Energy

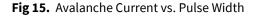












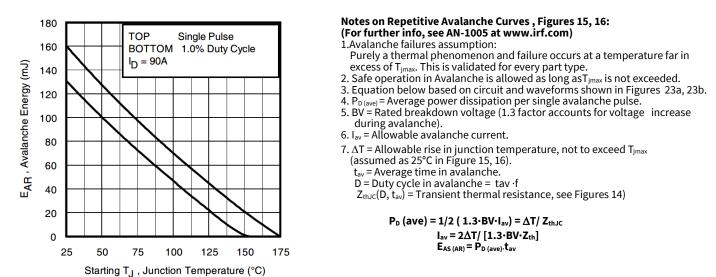


Fig 16. Maximum Avalanche Energy vs. Temperature

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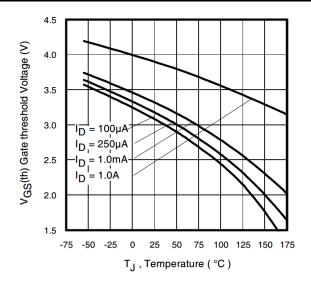


Fig 17. Threshold Voltage vs. Temperature

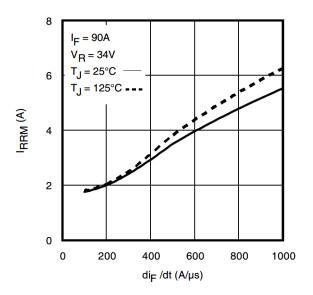


Fig 19. Typical Recovery Current vs. dif/dt

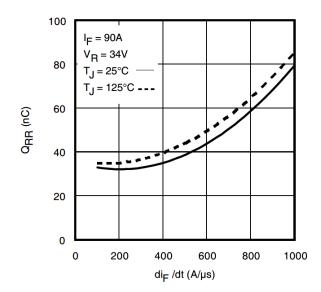


Fig 21. Typical Stored Charge vs. dif/dt

IRFR7440PbF/IRFU7440PbF

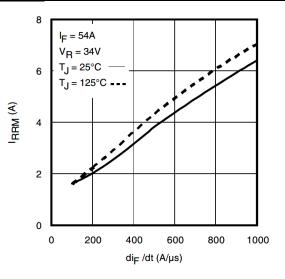


Fig 18. Typical Recovery Current vs. dif/dt

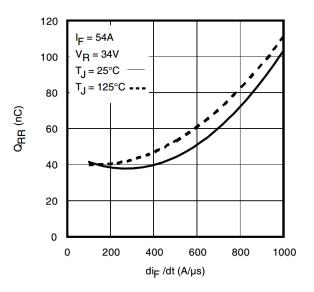


Fig 20. Typical Stored Charge vs. dif/dt

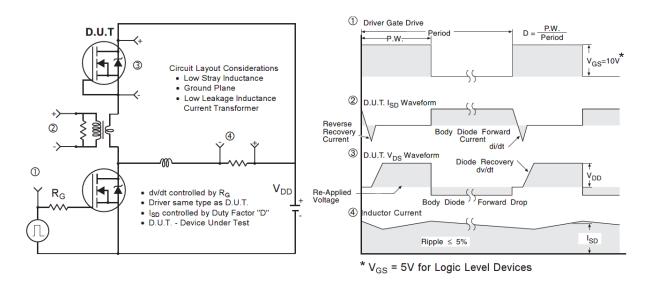
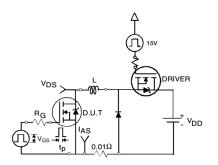


Fig 22. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs



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Fig 23a. Unclamped Inductive Test Circuit

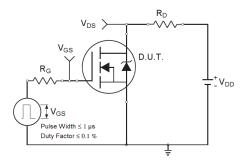


Fig 24a. Switching Time Test Circuit

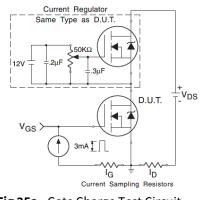


Fig 25a. Gate Charge Test Circuit

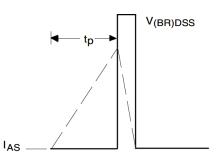


Fig 23b. Unclamped Inductive Waveforms

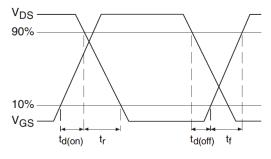


Fig 24b. Switching Time Waveforms

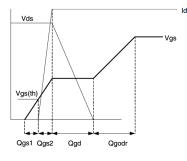
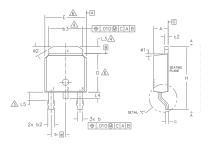
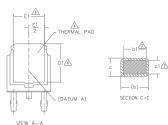


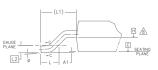
Fig 25b. Gate Charge Waveform

D-Pak (TO-252AA) Package Outline Dimensions are shown in millimeters (inches)









NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- A- LEAD DIMENSION UNCONTROLLED IN L5.
- A- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD. 5.- SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10
- [0.13 AND 0.25] FROM THE LEAD TIP.
- ▲ DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .006 [0.15] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- A- DIMENSION b1 & c1 APPLIED TO BASE METAL ONLY.
- A- DATUM A & B TO BE DETERMINED AT DATUM PLANE H. 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA

S		DIMEN	ISIONS		N
B	MILLIN	ETERS	INC	HES	0 T
0 L	MIN.	MAX.	MIN.	MAX.	ES
Α	2.18	2.39	.086	.094	
A1	-	0.13	-	.005	
b	0.64	0.89	.025	.035	
b1	0.64	0.79	.025	.031	7
b2	0.76	1.14	.030	.045	
b3	4.95	5.46	.195	.215	4
С	0.46	0.61	.018	.024	
c1	0.41	0.56	.016	.022	7
c2	0.46	0.89	.018	.035	
D	5.97	6.22	.235	.245	6
D1	5.21	-	.205	-	4
Ε	6.35	6.73	.250	.265	6
E1	4.32	-	.170	-	4
е	2.29	BSC	.090	BSC	
Н	9.40	10.41	.370	.410	
L	1.40	1.78	.055	.070	
L1	2.74	BSC	.108	REF.	
L2	0.51	BSC	.020	BSC	
L3	0.89	1.27	.035	.050	4
L4	-	1.02	-	.040	
L5	1.14	1.52	.045	.060	3
Ø	0*	10*	0*	10*	
ø1	0*	15*	0*	15*	
ø2	25*	35*	25*	35*	

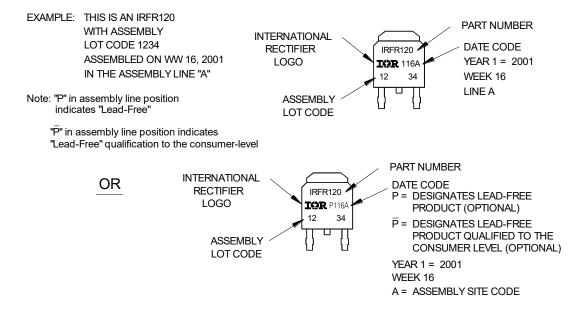
LEAD	ASSIGNMENTS

<u>HEXFET</u> 1.- GATE 2.- DRAIN 3.- SOURCE 4.- DRAIN

IGBT & CoPAK

- 1.- GATE 2.- COLLECTOR 3.- EMITTER 4.- COLLECTOR

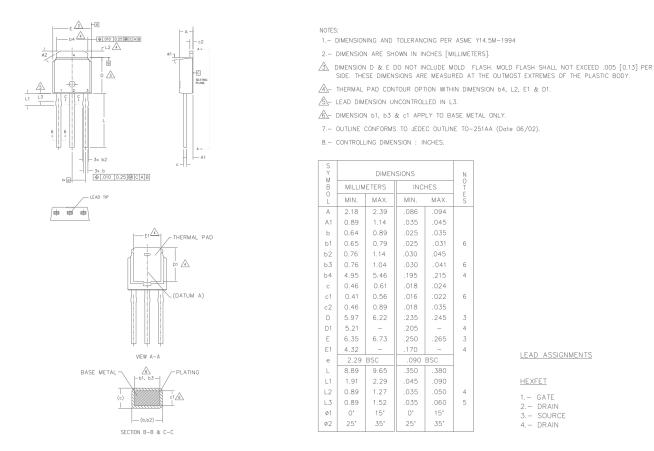
D-Pak (TO-252AA) Part Marking Information





IRFR7440PbF/IRFU7440PbF

I-Pak (TO-251AA) Package Outline Dimensions are shown in millimeters (inches)

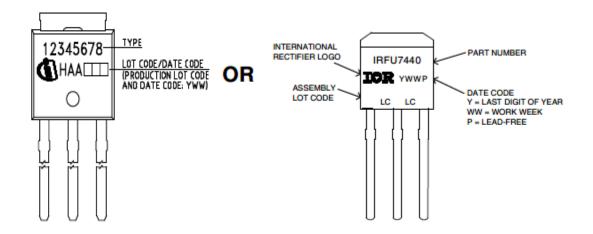


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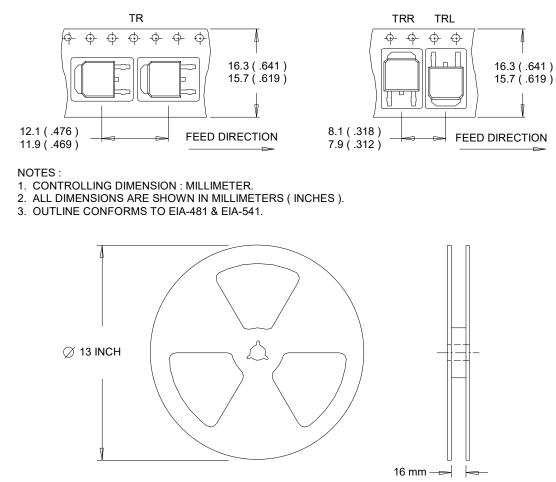
HEXFET

1 - GATE 2.- DRAIN 3.- SOURCE 4.- DRAIN

I-Pak (TO-251AA) Part Marking Information



D-Pak (TO-252AA) Tape & Reel Information Dimensions are shown in millimeters (inches)



NOTES :

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1. OUTLINE CONFORMS TO EIA-481.

Qualification Information[†]

Qualification Level	Industrial (per JEDEC JESD47F) ††		
Moisture Sensitivity Level	D-Pak	MSL1	
Moisture Sensitivity Level	I-Pak	(per JEDEC J-STD-020D) ^{††}	
RoHS Compliant	Yes		

† Qualification standards can be found at Infineon web site: <u>https://www.infineon.com/</u>

11 Applicable version of JEDEC standard at the time of product release.

Revision History

Date	Rev.	Comments
10/17/2012	2.1	Added I-Pak-All pages
		Updated datasheet based on corporate template.
05/01/2014	2.2	Added "Stong Fet" on header on page7.
		 Updated package outline and part marking on page 9 & 10.
01/06/2015 2.3	22	 Updated EAS (L =1mH) = 376mJ on page 2
	2.5	• Updated note 10 "Limited by T_{Jmax} , starting $T_J = 25^{\circ}$ C, L = 1mH, $R_G = 50\Omega$, $I_{AS} = 27A$, $V_{GS} = 10V$ ". on page 2
		Updated datasheet based on IFX template.
06/05/2023	2.4	• Removed "HEXFET [®] Power MOSFET /StrongIRFET [™] " and replace with "StrongIRFET [™] power MOSFET "-page1
		Updated Part marking -page 10



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